

Preliminary datasheet

EasyDUAL module with CoolSiC™ Trench MOSFET and PressFIT / NTC / TIM

Features

- Electrical features
 - $V_{DSS} = 1200 \text{ V}$
 - $I_{DN} = 100 \text{ A} / I_{DRM} = 200 \text{ A}$
 - Low inductive design
 - Low switching losses
- Mechanical features
 - PressFIT contact technology
 - Integrated NTC temperature sensor
 - Rugged mounting due to integrated mounting clamps
 - Pre-applied thermal interface material



Typical appearance

Potential applications

- High-frequency switching application
- DC/DC converter
- UPS systems
- DC charger for EV

Product validation

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

Description

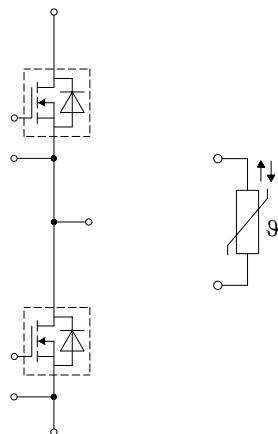


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1 Package

1 Package

Table 1 Insulation coordination

Parameter	Symbol	Note or test condition	Values	Unit
Isolation test voltage	V_{ISOL}	RMS, $f = 50 \text{ Hz}$, $t = 1 \text{ min}$	4.0	kV
Internal isolation		basic insulation (class 1, IEC 61140)	Al_2O_3	
Comparative tracking index	CTI		> 200	
Relative thermal index (electrical)	RTI	housing	140	°C

Table 2 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Stray inductance module	L_{sCE}			9		nH
Module lead resistance, terminals - chip	$R_{CC'EE'}$	$T_H = 25 \text{ °C}$, per switch		2		mΩ
Storage temperature	T_{stg}		-40		125	°C
Maximum baseplate operation temperature	T_{BPmax}				125	°C
Mounting force per clamp	F		20		50	N
Weight	G			24		g

Note: The current under continuous operation is limited to 25 A rms per connector pin.

Storage and shipment of modules with TIM => see AN 2012-07.

2 MOSFET

Table 3 Maximum rated values

Parameter	Symbol	Note or test condition	Values	Unit
Drain-source voltage	V_{DSS}		1200	V
Continuous DC drain current	I_{DDC}	$T_{vj} = 175 \text{ °C}$, $V_{GS} = 18 \text{ V}$	100	A
Repetitive peak drain current	I_{DRM}	verified by design, t_p limited by T_{vjmax}	200	A
Gate-source voltage, max. transient voltage	V_{GS}	$D < 0.01$	-10/23	V
Gate-source voltage, max. static voltage	V_{GS}		-7/20	V

Table 4 Recommended values

Parameter	Symbol	Note or test condition	Values	Unit
On-state gate voltage	$V_{GS(on)}$		15...18	V
Off-state gate voltage	$V_{GS(off)}$		-5...0	V

Table 5 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Drain-source on-resistance	$R_{DS(on)}$	$I_D = 100 \text{ A}$	$V_{GS} = 18 \text{ V}, T_{vj} = 25^\circ\text{C}$		8.1	mΩ
			$V_{GS} = 18 \text{ V}, T_{vj} = 125^\circ\text{C}$		13.1	
			$V_{GS} = 18 \text{ V}, T_{vj} = 150^\circ\text{C}$		15.1	
			$V_{GS} = 15 \text{ V}, T_{vj} = 25^\circ\text{C}$		9.7	
Gate threshold voltage	$V_{GS(th)}$	$I_D = 40 \text{ mA}, V_{DS} = V_{GS}, T_{vj} = 25^\circ\text{C}$, (tested after 1ms pulse at $V_{GS} = +20 \text{ V}$)	3.45	4.3	5.15	V
Total gate charge	Q_G	$V_{DD} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}$		0.297		μC
Internal gate resistor	R_{Gint}	$T_{vj} = 25^\circ\text{C}$		2.1		Ω
Input capacitance	C_{ISS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		8.8	nF
Output capacitance	C_{OSS}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		0.42	nF
Reverse transfer capacitance	C_{rss}	$f = 100 \text{ kHz}, V_{DS} = 800 \text{ V}, V_{GS} = 0 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		0.028	nF
C_{OSS} stored energy	E_{OSS}	$V_{DS} = 800 \text{ V}, V_{GS} = -3/18 \text{ V}, T_{vj} = 25^\circ\text{C}$			172	μJ
Drain-source leakage current	I_{DSS}	$V_{DS} = 1200 \text{ V}, V_{GS} = -3 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		0.06	μA
Gate-source leakage current	I_{GSS}	$V_{DS} = 0 \text{ V}, T_{vj} = 25^\circ\text{C}$	$V_{GS} = 20 \text{ V}$		400	nA
Turn-on delay time (inductive load)	$t_{d(on)}$	$I_D = 100 \text{ A}, R_{Gon} = 8.2 \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		53	ns
			$T_{vj} = 125^\circ\text{C}$		53	
			$T_{vj} = 150^\circ\text{C}$		53	
Rise time (inductive load)	t_r	$I_D = 100 \text{ A}, R_{Gon} = 8.2 \Omega, V_{DD} = 600 \text{ V}, V_{GS} = -3/18 \text{ V}$	$T_{vj} = 25^\circ\text{C}$		70	ns
			$T_{vj} = 125^\circ\text{C}$		70	
			$T_{vj} = 150^\circ\text{C}$		70	

(table continues...)

Table 5 (continued) Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Turn-off delay time (inductive load)	$t_{d\ off}$	$I_D = 100\ A, R_{Goff} = 2.7\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$		73	ns
			$T_{vj} = 125\ ^\circ C$		79	
			$T_{vj} = 150\ ^\circ C$		81	
Fall time (inductive load)	t_f	$I_D = 100\ A, R_{Goff} = 2.7\ \Omega, V_{DD} = 600\ V, V_{GS} = -3/18\ V$	$T_{vj} = 25\ ^\circ C$		20	ns
			$T_{vj} = 125\ ^\circ C$		20	
			$T_{vj} = 150\ ^\circ C$		20	
Turn-on energy loss per pulse	E_{on}	$I_D = 100\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Gon} = 8.2\ \Omega, di/dt = 3.88\ kA/\mu s (T_{vj} = 150\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$		2.87	mJ
			$T_{vj} = 125\ ^\circ C$		3.05	
			$T_{vj} = 150\ ^\circ C$		3.12	
Turn-off energy loss per pulse	E_{off}	$I_D = 100\ A, V_{DD} = 600\ V, L_\sigma = 35\ nH, V_{GS} = -3/18\ V, R_{Goff} = 2.7\ \Omega, dv/dt = 24\ kV/\mu s (T_{vj} = 150\ ^\circ C)$	$T_{vj} = 25\ ^\circ C$		0.75	mJ
			$T_{vj} = 125\ ^\circ C$		0.81	
			$T_{vj} = 150\ ^\circ C$		0.82	
SC data	I_{SC}	$V_{GS} = -5/15\ V, V_{DD} = 800\ V, V_{DSmax} = V_{DSS} - L_{SDS} * di/dt, R_G = 10\ \Omega$	$t_p = 2\ \mu s, T_{vj} = 25\ ^\circ C$		840	A
			$t_p = 2\ \mu s, T_{vj} = 150\ ^\circ C$		820	
Thermal resistance, junction to heat sink	R_{thJH}	per MOSFET, Valid with IFX pre-applied Thermal Interface Material			0.48	K/W
Temperature under switching conditions	$T_{vj\ op}$			-40	150	°C

Note: The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Note AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

3 Body diode (MOSFET)

Table 6 Maximum rated values

Parameter	Symbol	Note or test condition		Values	Unit
DC body diode forward current	I_{SD}	$T_{vj} = 175\ ^\circ C, V_{GS} = -3\ V$	$T_H = 65\ ^\circ C$	55	A

Table 7 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Forward voltage	V_{SD}	$I_{SD} = 100 \text{ A}, V_{GS} = -3 \text{ V}$	$T_{vj} = 25 \text{ }^{\circ}\text{C}$		4.2	5.35
			$T_{vj} = 125 \text{ }^{\circ}\text{C}$		3.9	
			$T_{vj} = 150 \text{ }^{\circ}\text{C}$		3.85	

4 NTC-Thermistor

Table 8 Characteristic values

Parameter	Symbol	Note or test condition	Values			Unit
			Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_{NTC} = 25 \text{ }^{\circ}\text{C}$		5		$\text{k}\Omega$
Deviation of R_{100}	$\Delta R/R$	$T_{NTC} = 100 \text{ }^{\circ}\text{C}, R_{100} = 493 \Omega$	-5		5	%
Power dissipation	P_{25}	$T_{NTC} = 25 \text{ }^{\circ}\text{C}$			20	mW
B-value	$B_{25/50}$	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298,15 \text{ K}))]$		3375		K
B-value	$B_{25/80}$	$R_2 = R_{25} \exp[B_{25/80}(1/T_2 - 1/(298,15 \text{ K}))]$		3411		K
B-value	$B_{25/100}$	$R_2 = R_{25} \exp[B_{25/100}(1/T_2 - 1/(298,15 \text{ K}))]$		3433		K

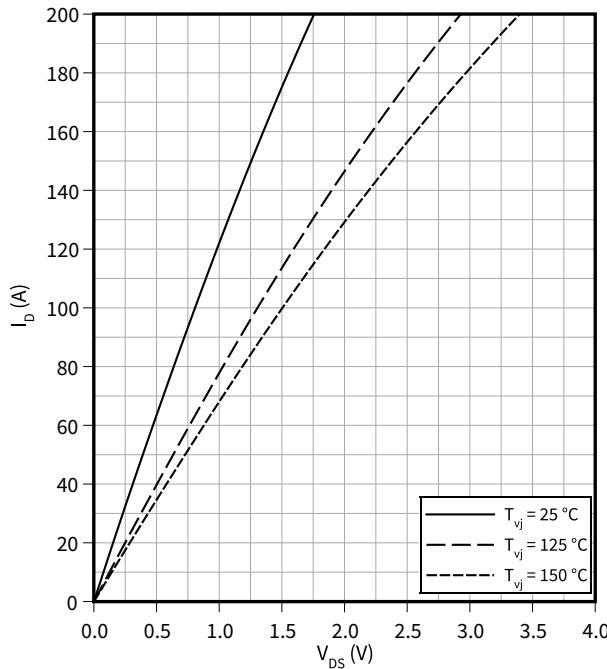
Note: Specification according to the valid application note.

5 Characteristics diagrams

Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$

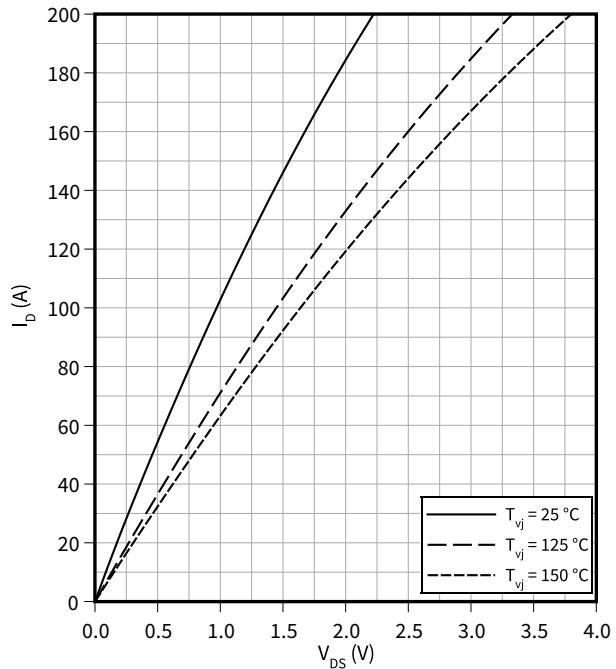
$V_{GS} = 18 \text{ V}$



Output characteristic (typical), MOSFET

$I_D = f(V_{DS})$

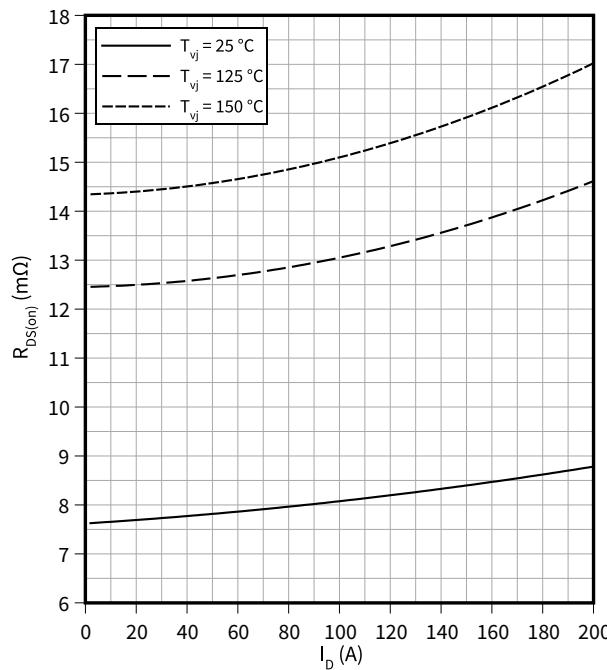
$V_{GS} = 15 \text{ V}$



Drain source on-resistance (typical), MOSFET

$R_{DS(on)} = f(I_D)$

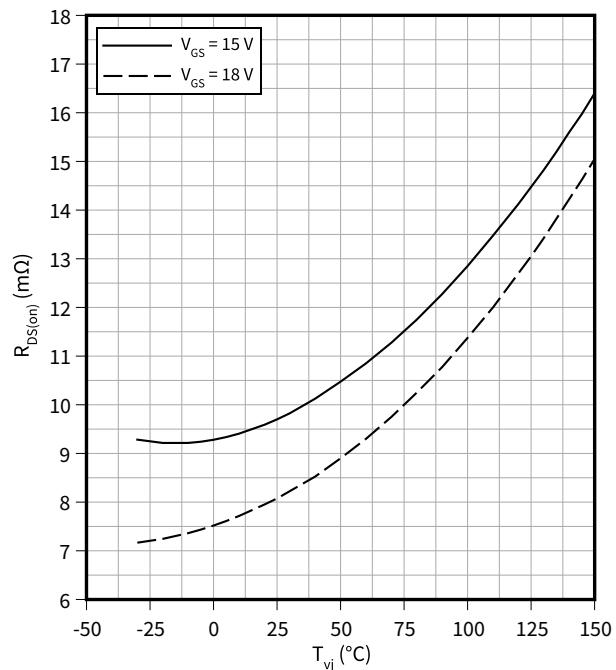
$V_{GS} = 18 \text{ V}$



Drain source on-resistance (typical), MOSFET

$R_{DS(on)} = f(T_{vj})$

$I_D = 100 \text{ A}$

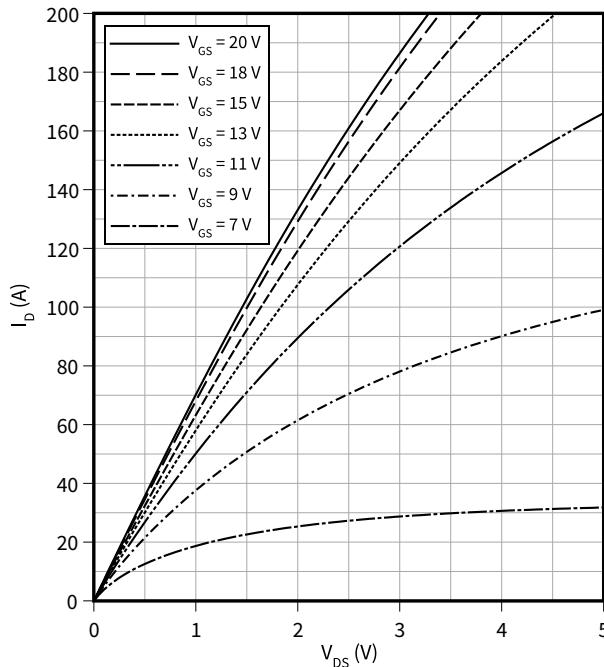


5 Characteristics diagrams

Output characteristic field (typical), MOSFET

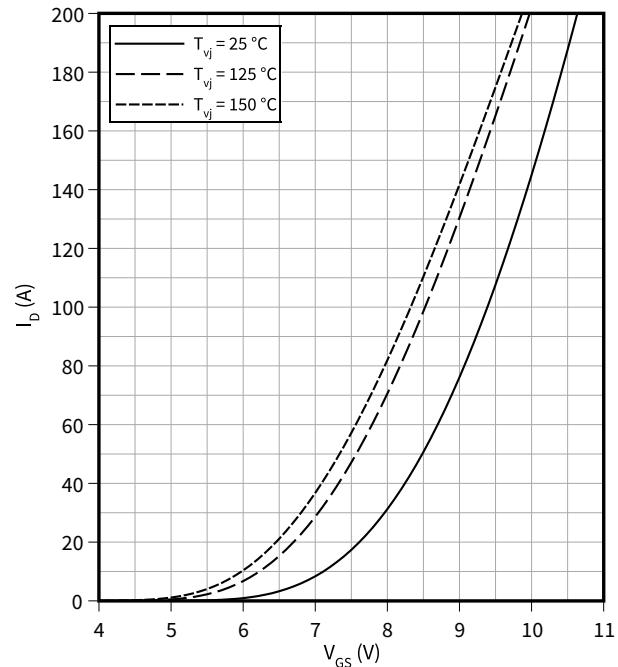
$$I_D = f(V_{DS})$$

$$T_{vj} = 150^\circ\text{C}$$

**Transfer characteristic (typical), MOSFET**

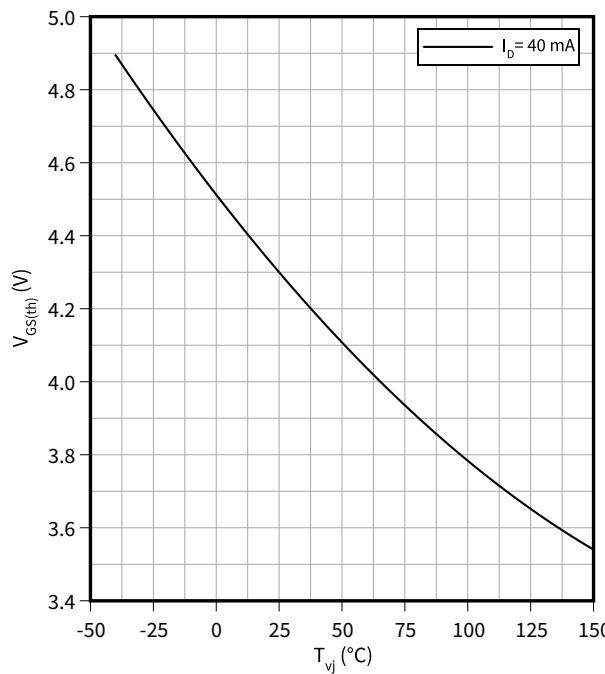
$$I_D = f(V_{GS})$$

$$V_{DS} = 20\text{ V}$$

**Gate-source threshold voltage (typical), MOSFET**

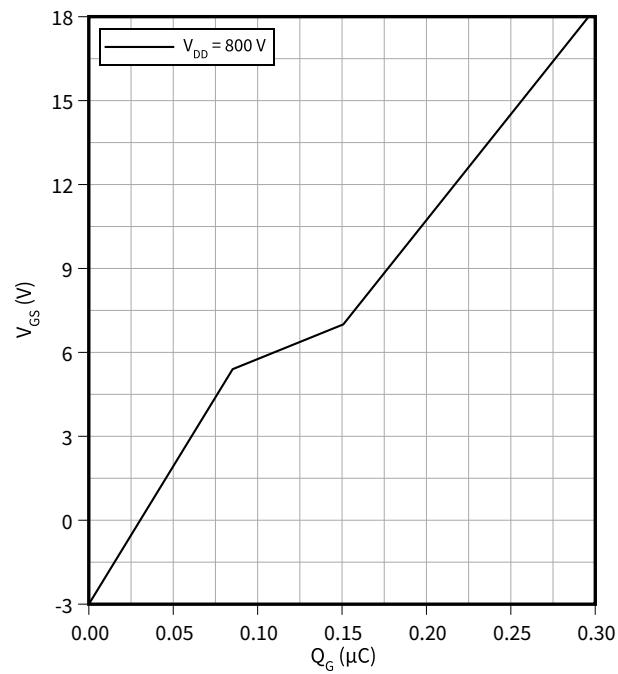
$$V_{GS(th)} = f(T_{vj})$$

$$V_{GS} = V_{DS}$$

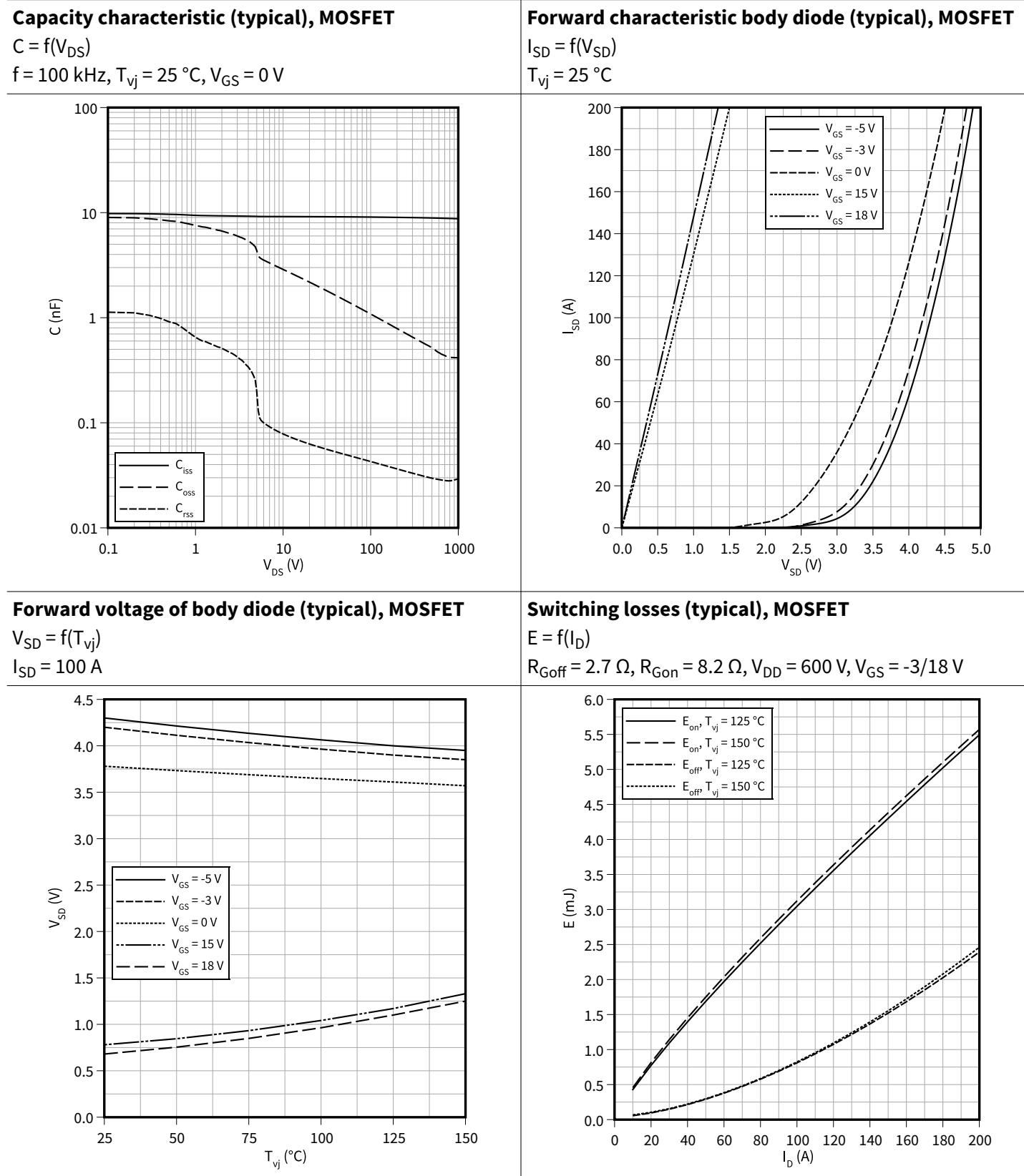
**Gate charge characteristic (typical), MOSFET**

$$V_{GS} = f(Q_G)$$

$$I_D = 100\text{ A}, T_{vj} = 25^\circ\text{C}$$



5 Characteristics diagrams

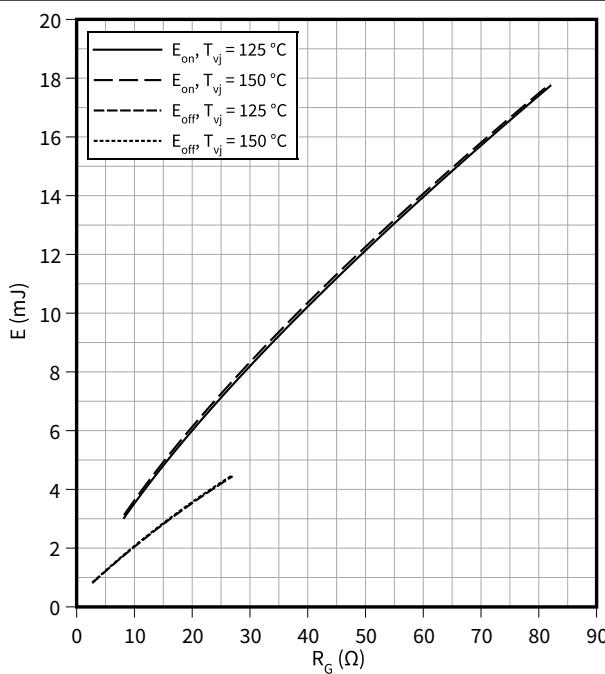


5 Characteristics diagrams

Switching losses (typical), MOSFET

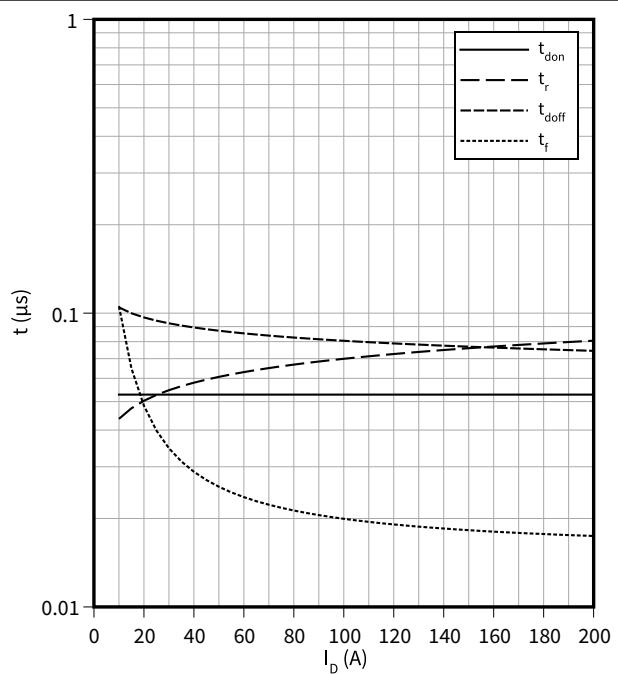
$$E = f(R_G)$$

$V_{DD} = 600 \text{ V}$, $I_D = 100 \text{ A}$, $V_{GS} = -3/18 \text{ V}$

**Switching times (typical), MOSFET**

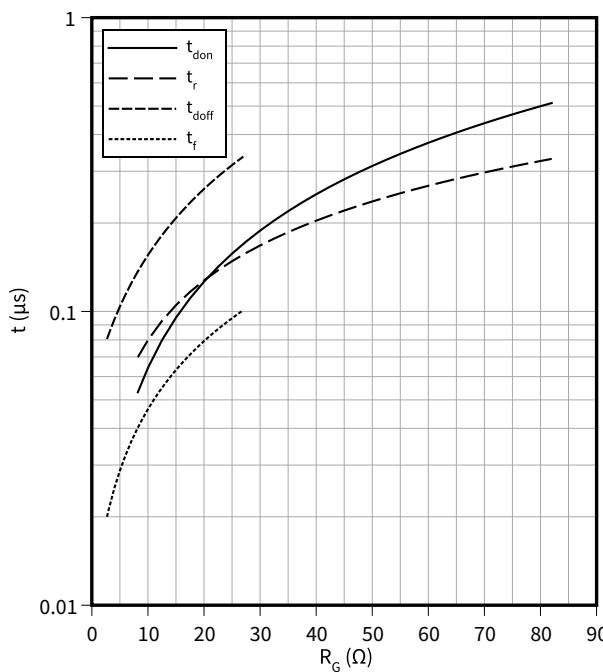
$$t = f(I_D)$$

$R_{Goff} = 2.7 \Omega$, $R_{Gon} = 8.2 \Omega$, $V_{DD} = 600 \text{ V}$, $T_{vj} = 150^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$

**Switching times (typical), MOSFET**

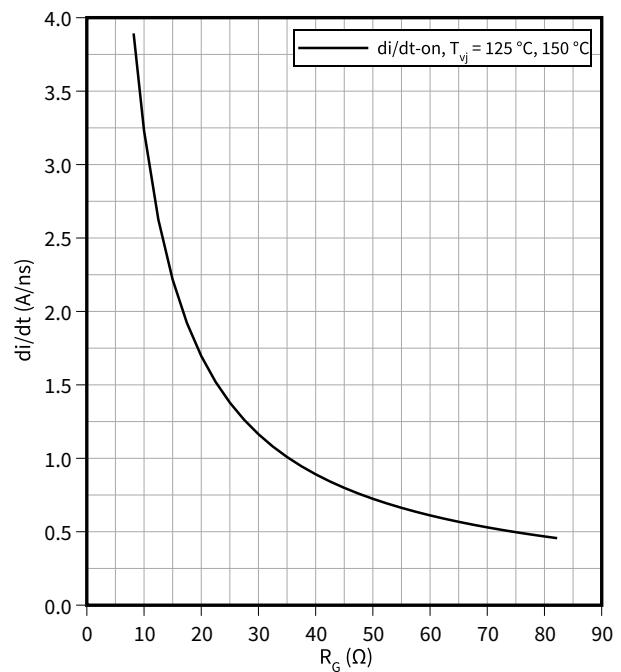
$$t = f(R_G)$$

$V_{DD} = 600 \text{ V}$, $I_D = 100 \text{ A}$, $T_{vj} = 150^\circ\text{C}$, $V_{GS} = -3/18 \text{ V}$

**Current slope (typical), MOSFET**

$$di/dt = f(R_G)$$

$V_{DD} = 600 \text{ V}$, $I_D = 100 \text{ A}$, $V_{GS} = -3/18 \text{ V}$

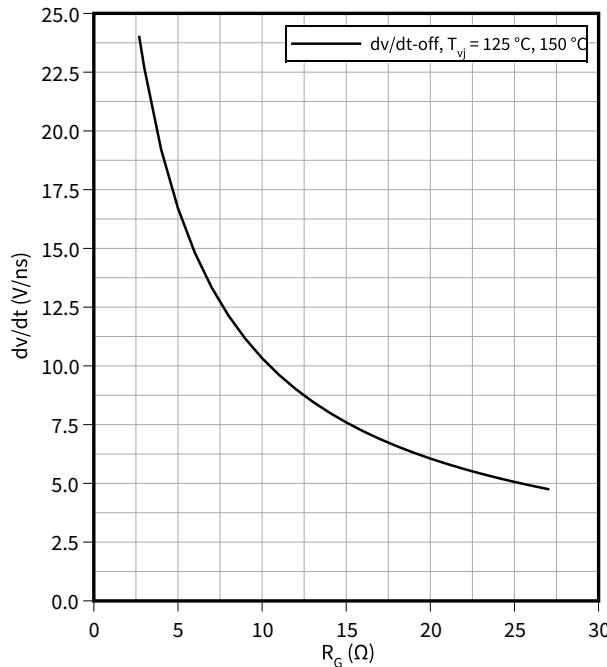


5 Characteristics diagrams

Voltage slope (typical), MOSFET

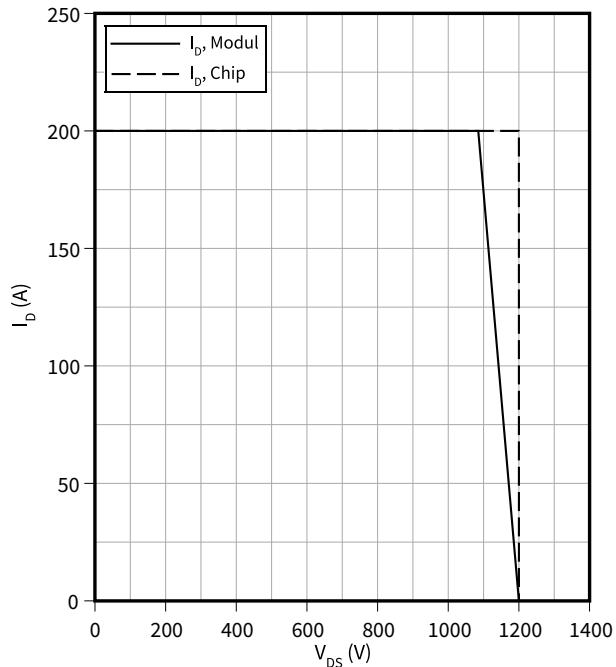
$$dv/dt = f(R_G)$$

$$V_{DD} = 600 \text{ V}, I_D = 100 \text{ A}, V_{GS} = -3/18 \text{ V}$$

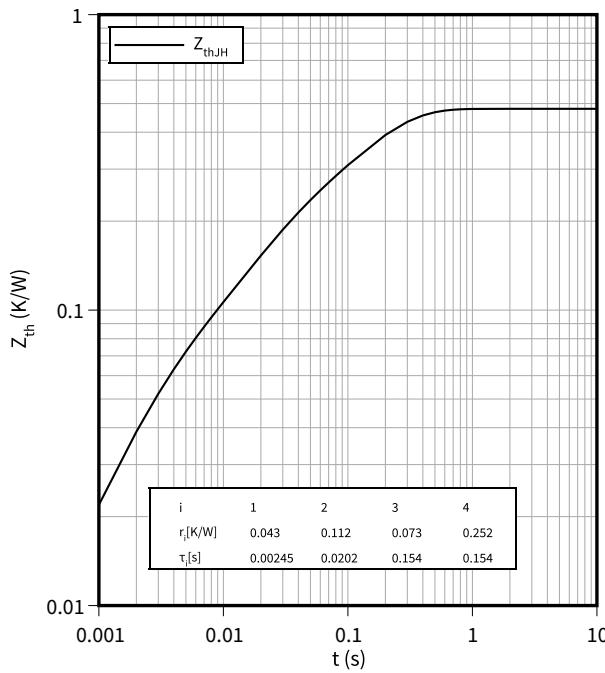
**Reverse bias safe operating area (RBSOA), MOSFET**

$$I_D = f(V_{DS})$$

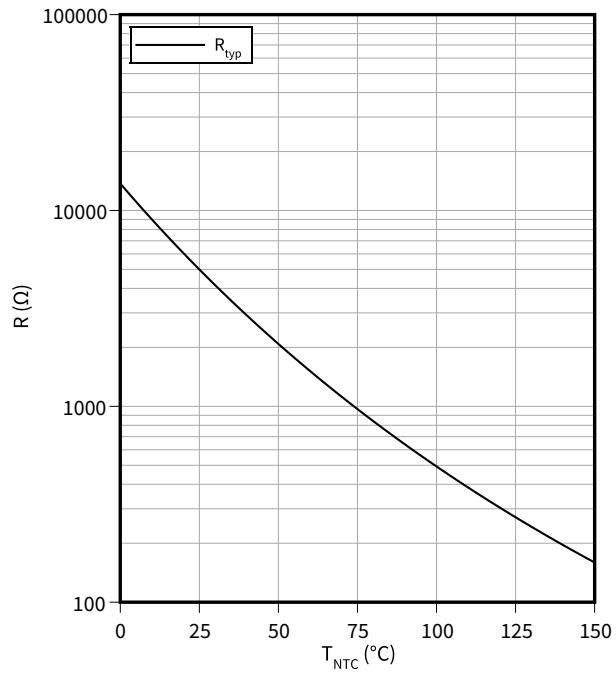
$$R_{Goff} = 2.7 \Omega, T_{vj} = 150^\circ\text{C}, V_{GS} = -3/18 \text{ V}$$

**Transient thermal impedance , MOSFET**

$$Z_{th} = f(t)$$

**Temperature characteristic (typical), NTC-Thermistor**

$$R = f(T_{NTC})$$



6 Circuit diagram

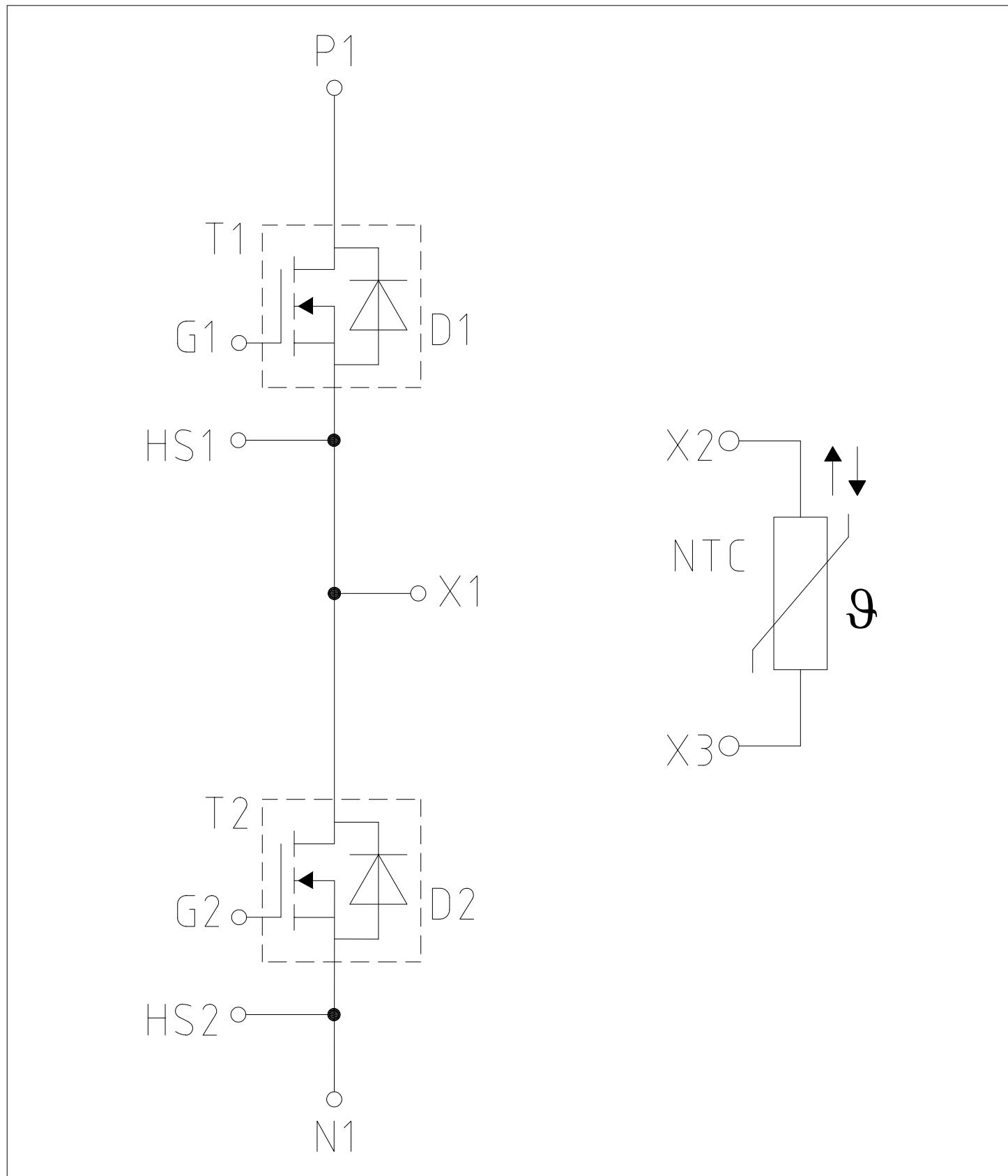


Figure 1

7 Package outlines

7 Package outlines

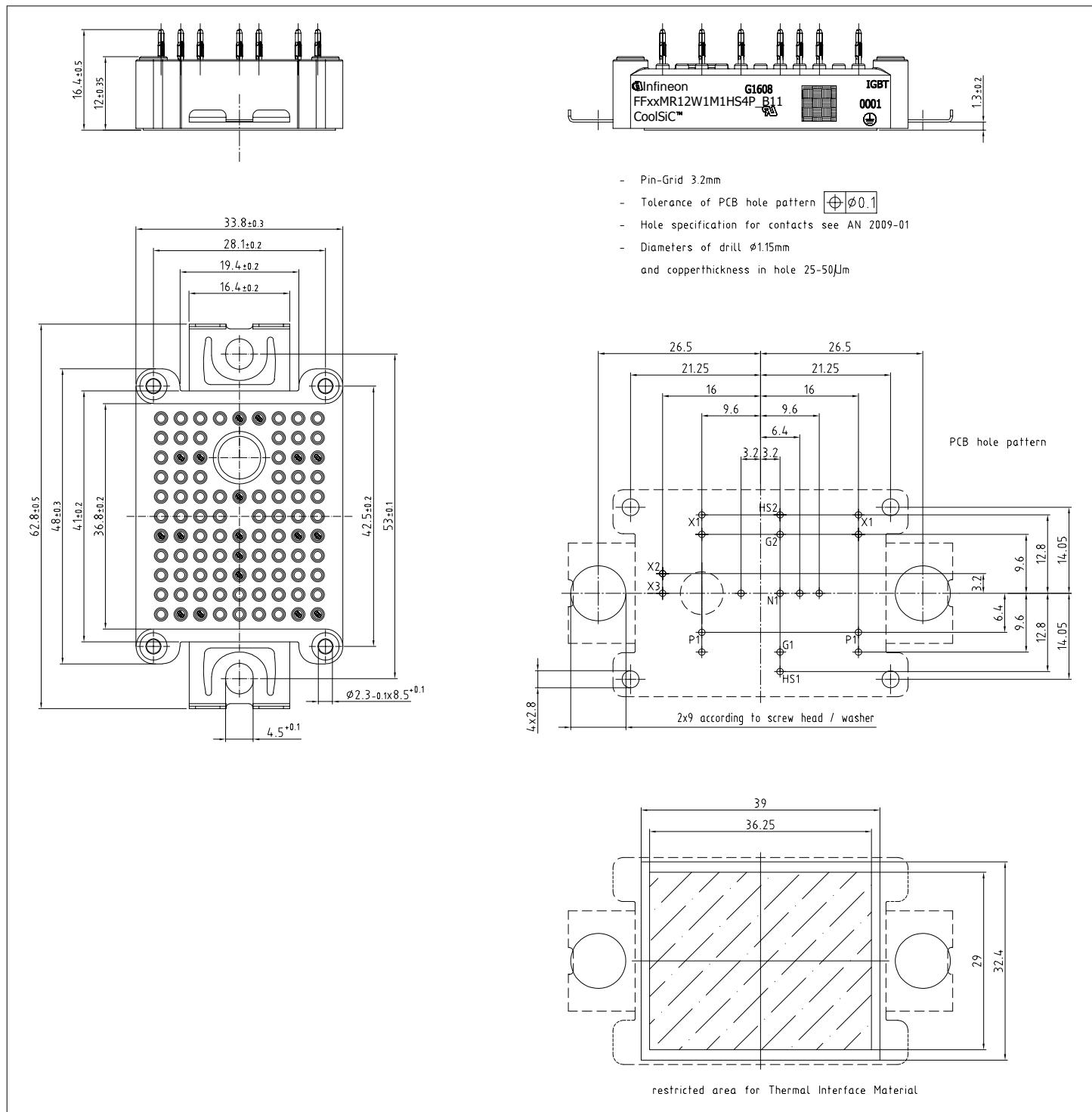


Figure 2

8 Module label code

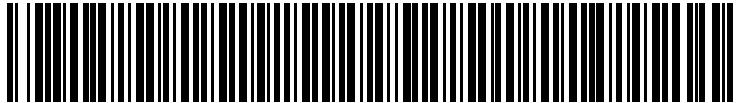
Module label code			
Code format	Data Matrix		Barcode Code128
Encoding	ASCII text		Code Set A
Symbol size	16x16		23 digits
Standard	IEC24720 and IEC16022		IEC8859-1
Code content	<p><i>Content</i></p> <p>Module serial number Module material number Production order number Date code (production year) Date code (production week)</p>	<p><i>Digit</i></p> <p>1 – 5 6 - 11 12 - 19 20 – 21 22 – 23</p>	<p><i>Example</i></p> <p>71549 142846 55054991 15 30</p>
Example			71549142846550549911530

Figure 3

Revision history

Document revision	Date of release	Description of changes
0.10	2022-10-19	Initial version
0.20	2023-01-24	Preliminary datasheet
0.30	2023-02-07	Preliminary datasheet

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Edition 2023-02-07

Published by

**Infineon Technologies AG
81726 Munich, Germany**

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**Document reference
IFX-ABF649-003**

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[FF150R12KE3G](#) [FF200R06KE3](#) [FF200R06YE3](#) [FF300R06KE3_B2](#) [FF600R12IP4V](#) [FF800R17KP4_B2](#) [FF900R12IE4V](#)
[FP06R12W1T4_B3](#) [FP100R07N3E4](#) [FP100R07N3E4_B11](#) [FP10R06W1E3_B11](#) [FP10R12W1T4_B11](#) [FP10R12YT3](#) [FP15R12W2T4](#)
[FP15R12YT3](#) [FP20R06W1E3](#) [FP30R06W1E3](#) [FP40R12KT3G](#) [FP75R06KE3](#) [FS10R12YE3](#) [FS150R07PE4](#) [FS150R12PT4](#)
[FS150R17N3E4_B11](#) [FS20R06W1E3_B11](#) [FS30R06W1E3_B11](#) [FS75R12KE3G](#) [FS75R12W2T4_B11](#) [FZ1600R17HP4_B2](#)
[FZ300R12KE3G](#) [FZ400R17KE3](#) [FZ400R17KE4](#) [FZ600R65KE3](#) [DF1000R17IE4D_B2](#) [APTGT75DA60T1G](#) [DZ800S17K3](#) [F12-25R12KT4G](#)
[F3L200R12W2H3_B11](#) [F3L300R12ME4_B22](#) [F3L75R07W2E3_B11](#) [F4-150R12KS4](#) [F475R07W1H3B11ABOMA1](#)
[FD1400R12IP4D](#) [FD400R12KE3_B5](#)